

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/773,474	BISHARA, NAFEA	
Examiner		Art Unit		Page 1 of 1
Hong Cho		2616		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0012345 A1	01-2002	Kalkunte et al.	370/389
*	B	US-2002/0009081 A1	01-2002	Sampath et al.	370/389
*	C	US-6,457,059 B1	09-2002	Kobayashi, Naofumi	709/242
*	D	US-6,553,028 B1	04-2003	Tang et al.	370/389
*	E	US-6,950,431 B1	09-2005	Nozaki et al.	370/390
*	F	US-7,009,968 B2	03-2006	Ambe et al.	370/389
*	G	US-7,050,430 B2	05-2006	Kalkunte et al.	370/389
*	H	US-7,099,317 B2	08-2006	Ambe et al.	370/389
*	I	US-7,139,269 B2	11-2006	Kalkunte et al.	370/389
J	US-				
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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